

U.S. PTO
10/003224

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**PATENT NUMBER and
ISSUE DATE**

U.S. UTILITY Patent Application

10/003224

APPL NUM 10003224	FILING DATE 10/26/2001	CLASS 378	SUBCLASS 306	GAU 2881/2882	EXAMINER <i>Johnston</i>
**APPLICANTS: Larson Paul; Moulder John; Watson David; Perloff David; <div style="text-align: right;">2881</div>					
**CONTINUING DATA VERIFIED: 250/306 <i>Johnston</i> THIS APPLICATION IS A CIP OF 10/075,571 10/26/2001					
** FOREIGN APPLICATIONS VERIFIED: <i>none of</i>					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>		ATTORNEY DOCKET NO 278.00060120	
Foreign priority claimed <input type="checkbox"/> yes <input checked="" type="checkbox"/> no 35 USC 119 conditions met <input type="checkbox"/> yes <input checked="" type="checkbox"/> no Verified and Acknowledged Examiners's initials <i>[Signature]</i>				TITLE : System and method for characterization of thin films	

U.S. DEPT. OF COMM./PAT. & TM.-PTO-435L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
ISSUE FEE		DRAWING	
Amount Due	Date Paid	Sheet Drwg.	Figs. Drwg.
		Print Fig.	
<input type="checkbox"/> TERMINAL DISCLAIMER		Application Examiner	
		PREPARED FOR ISSUE	
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